

## FDFS2P103

## Integrated P-Channel PowerTrench® MOSFET and Schottky Diode

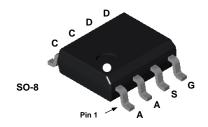
### **General Description**

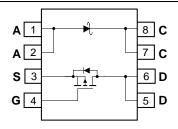
The FDFS2P103 combines the exceptional performance of Fairchild's PowerTrench MOSFET technology with a very low forward voltage drop Schottky barrier rectifier in an SO-8 package.

This device is designed specifically as a single package solution for DC to DC converters. It features a fast switching, low gate charge MOSFET with very low onstate resistance. The independently connected Schottky diode allows its use in a variety of DC/DC converter topologies.

### **Features**

- -5.3 A, -30V  $R_{DS(ON)} = 59 \text{ m}\Omega$  @  $V_{GS} = -10 \text{ V}$   $R_{DS(ON)} = 92 \text{ m}\Omega$  @  $V_{GS} = -4.5 \text{ V}$
- V<sub>F</sub> < 0.52 V @ 1 A (T<sub>J</sub> = 125°C)
   V<sub>F</sub> < 0.57 V @ 1 A (T<sub>J</sub> = 25°C)
- Schottky and MOSFET incorporated into single power surface mount SO-8 package
- Electrically independent Schottky and MOSFET pinout for design flexibility





### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	MOSFET Drain-Source Voltage		-30	V
V <sub>GSS</sub>	MOSFET Gate-Source Voltage		±25	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	-5.3	А
	- Pulsed		-20	
P <sub>D</sub>	Power Dissipation for Dual Operation		2	W
	Power Dissipation for Single Operation	(Note 1a)	1.6	
		(Note 1b)	1	
		(Note 1c)	0.9	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C
V <sub>RRM</sub>	Schottky Repetitive Peak Reverse Voltage		30	V
Io	Schottky Average Forward Current	(Note 1a)	1	А

### **Package Marking and Ordering Information**

Device Marking	Device	Reel Size	Tape width	Quantity
FDFS2P103	FDFS2P103	13"	12mm	2500 units

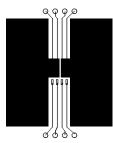
Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
Off Char	acteristics	-			I.	•	l
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V$ , I	<sub>D</sub> = -250 μA	-30			V
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu\text{A}, \text{Ref}$	erenced to 25°C		-23		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V}, \text{ V}$	<sub>'GS</sub> = 0 V			-1	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	V <sub>GS</sub> = 25 V, V	<sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -25 \text{ V}, \text{ V}$	<sub>DS</sub> = 0 V			-100	nA
On Char	acteristics (Note 2)				•		
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS},$ I	<sub>D</sub> = -250 μA	-1	-1.7	-3	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu\text{A}, \text{Ref}$			4.5		mV/°C
R <sub>DS(on)</sub>	Static Drain-Source	$V_{GS} = -10 \text{ V},  I$	<sub>D</sub> = -5.3 A		46	59	mΩ
	On–Resistance	$V_{GS} = -4.5 \text{ V},  I$	=		70	92	
		V <sub>GS</sub> =-10 V, I <sub>D</sub> =-			63	88	
I <sub>D(on)</sub>	On–State Drain Current	$V_{GS} = -10 \text{ V},  \  \   \  \   \  \   \  \   \  $		-20			Α
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = -5V$ ,	$I_D = -5.3 \text{ A}$		10		S
Dynamic	Characteristics						
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -15 \text{ V},  \  \   \  \   \  \   \  \   \  \   \  \ $	$I_{GS} = 0 \text{ V},$		528		pF
Coss	Output Capacitance	f = 1.0 MHz			132		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				70		pF
Switchin	ng Characteristics (Note 2)						
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -15 \text{ V},  I$	<sub>D</sub> = -1 A,		7	14	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = -10 \text{ V},  F$	$V_{GS} = -10 \text{ V},  R_{GEN} = 6 \Omega$		13	24	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	1			14	25	ns
t <sub>f</sub>	Turn-Off Fall Time				9	17	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = -15 \text{ V},  I$	<sub>D</sub> = -5.3 A,		5.3	8	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = -5 V			2.2		nC
Q <sub>gd</sub>	Gate-Drain Charge				1.6		nC
Drain-S	ource Diode Characteristics	and Maximum	Ratings				
Is	Maximum Continuous Drain-Source					-1.3	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_S = -1.3 \text{ A}  \text{(Note 2)}$			-0.7	-1.2	V
Schottky	/ Diode Characteristics						
I <sub>R</sub>	Reverse Leakage	V <sub>R</sub> = 30 V	$T_J = 25^{\circ}C$		15	100	μΑ
	_		T <sub>J</sub> = 125°C		6	30	mA
$V_F$	Forward Voltage	I <sub>F</sub> = 1A	T <sub>J</sub> = 25°C		0.41	0.57	V
			$T_{J} = 125^{\circ}C$		0.32	0.52	V

### **Thermal Characteristics**

R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	135	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

#### Notes

1.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 78°C/W when mounted on a 0.5in<sup>2</sup> pad of 2 oz copper



125°C/W when mounted on a 0.02 in<sup>2</sup> pad of 2 oz copper



135°C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300 $\mu$ s, Duty Cycle < 2.0%

## **Typical Characteristics**

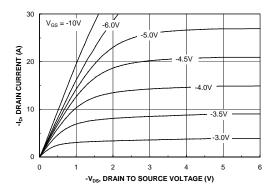


Figure 1. On-Region Characteristics.

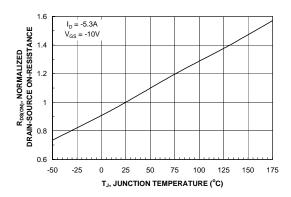


Figure 3. On-Resistance Variation with Temperature.

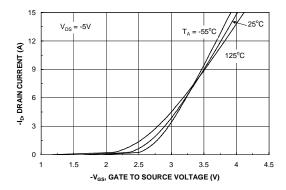


Figure 5. Transfer Characteristics.

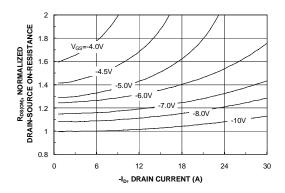


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

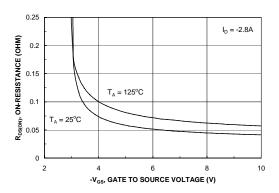


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

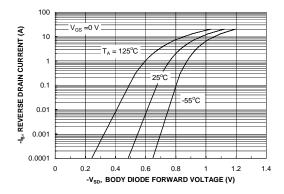
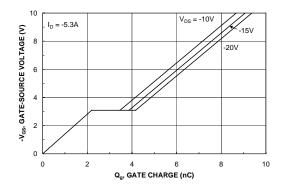


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

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## **Typical Characteristics**



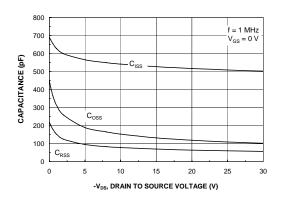


Figure 7. Gate Charge Characteristics.

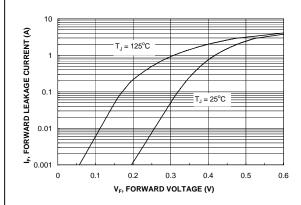


Figure 8. Capacitance Characteristics.

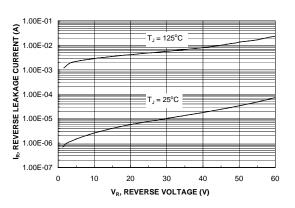


Figure 9. Schottky Diode Forward Voltage.



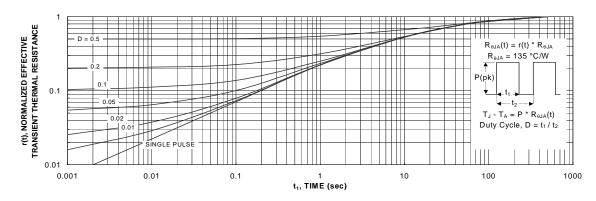
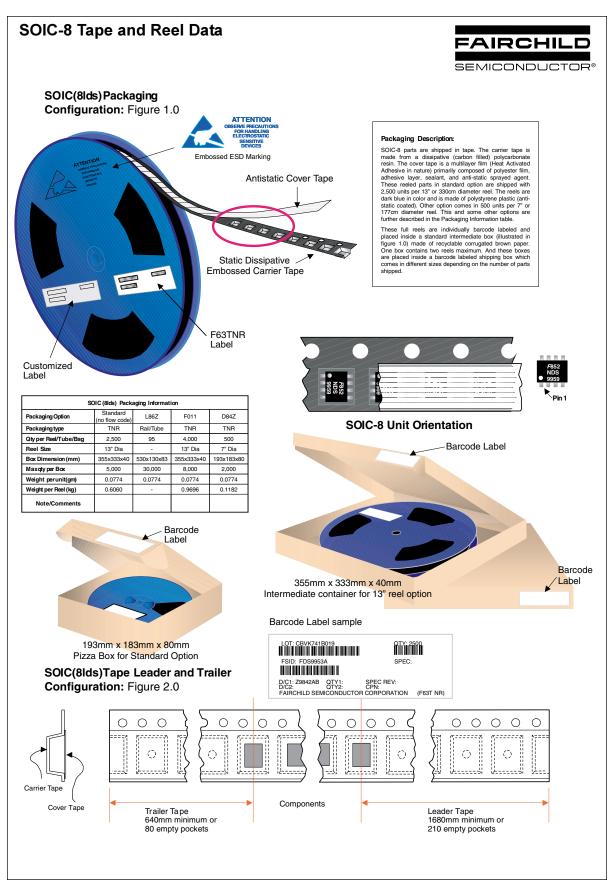


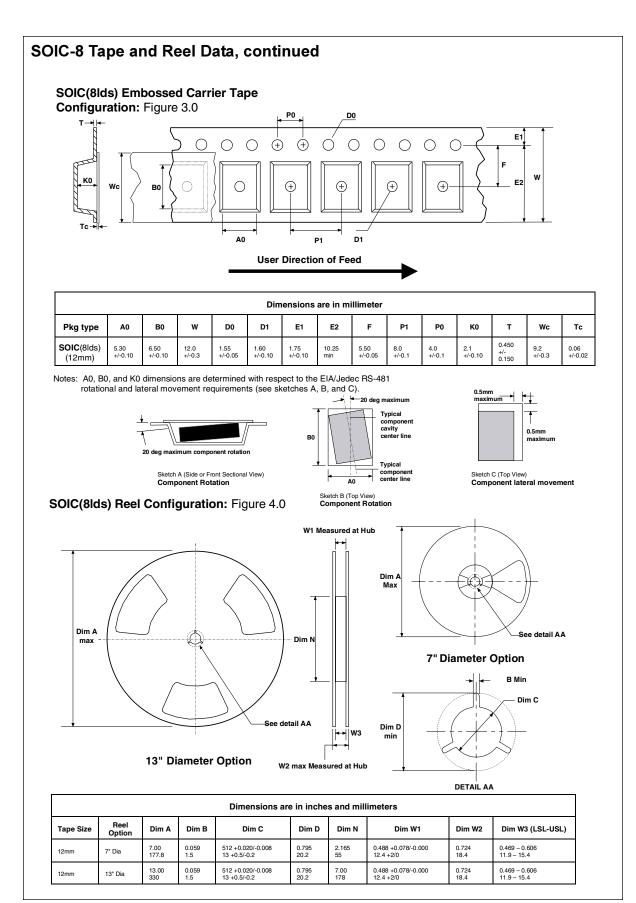
Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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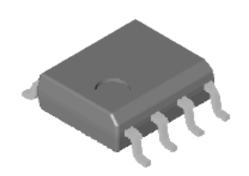
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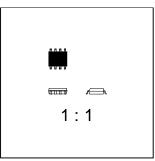


## **SOIC-8 Package Dimensions**



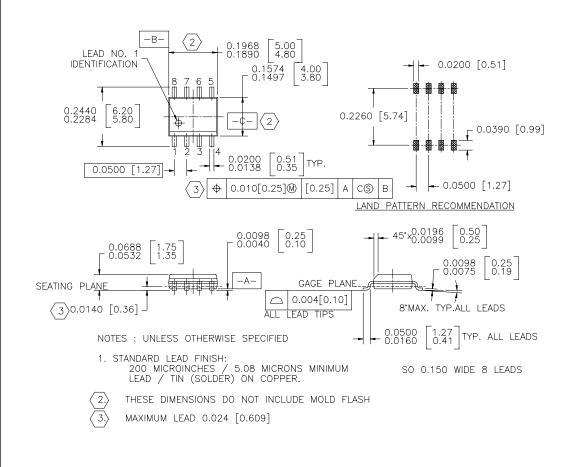
# SOIC-8 (FS PKG Code S1)





Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

Part Weight per unit (gram): 0.0774



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